

Controlled plasma tuning of MoS₂ based photodetector: From visible to ultraviolet photo response

Huda Musa MUTLAQ^{1,*}, and Ali Jabbar FRAIH¹

¹ College of Science, Wasit University, Al Kut, Wasit, Iraq

*Corresponding author e-mail: hudamusa@uowasit.edu.iq

Received date: 18 July 2021 Revised date 15 September 2021 Accepted date: 17 September 2021

Keywords:

MoS₂; Oxygen plasma; Photodetector; Visible; Ultraviolet

1. Introduction

The emergence of unique properties in two-dimensional (2D) materials has made them very promising for electronic and optoelectronic applications [1]. In this regards, transition metal dichalcogenides (TMDs) as optically active 2D materials, have attracted considerable attention [2]. TMDs are a group of 2D materials with MX₂, which M is a transition metal atom and X is a chalcogen atom [3]. In this structure, the transition metal atom is sandwiched between two chalcogen atoms. These materials have an indirect energy gap in bulk crystal, but are interestingly converted to a direct energy gap in monolayer [4]. Today, many layered TMDs have been introduced, such as: molybdenum disulfide (MoS₂) [5,6], Tungsten disulfide (WS₂) [7], Molybdenum ditelluride (MoTe₂) [8] and so forth [2]. Among the attractive structures of TMDs, more attention is allocated to MoS₂ where it is dramatically used in optoelectronic applications [9].

Mono- and few- layers of MoS_2 are synthesized in different ways, the most important of which are: mechanical exfoliation [10], sonicationassisted solvent exfoliation [11], and solid gas reaction of Mo powders [12,13]. The solvent-based sonication method has received more attention due to its easy, cheap and mass production of mono- and few- layers of MoS_2 [11].

Molybdenum has historically been used as lubricant and catalysis, but today it is increasingly employed in optoelectronic devices such as photodetectors [14], solar cells [15], and light emitting diodes [16] due to its high carrier mobility, modulated energy band gap, and lightmatter interaction[11,14,15,17]. MoS₂ based photodetectors show the ability to detect light in the visible range with a photoresponsivity of up to 1000 A/W and a response time of few microseconds [18,19].

Abstract

Among diverse family of two-dimensional materials, molybdenum disulfide (MoS₂) is one of the most promising materials for optical applications thanks to its tunable optical energy bandgap. In this work, a MoS₂ based photodetector is fabricated and its optical properties is investigated. With the help of controlled oxygen plasma bombardment, its photoresponse is tuned from visible to ultraviolet region. The photodetector was subjected to three bombardment times of 60 s, 120 s, and 180 s, and it was observed that 180 s irradiation resulted in a change in the optical response range of the photodetector from visible to ultraviolet. In fact, by doping MoS₂ sheets with oxygen ions, they are replaced with sulfur atoms and partially MoS₂ is converted to oxide which its energy band gap increases. Raman analysis shows that the structure of MoS₂ is preserved even after plasma irradiation. However, due to the bombardment, response time of the tuned photodetector is slowed down due to the increase of trap states.

MoS₂-based photodetectors cover a wide photodetection range from visible to ultraviolet regions and are not suitable for detecting specific wavelengths [19]. Moreover, few number of research have been reported so far on 2D material based photodetectors for the ultraviolet region. Therefore, with energy bandgap engineering, it could be possible to develop a MoS₂ based photodetector that could operate only in the ultraviolet area. One of the methods that can be used to change the band gap of MoS₂ is oxygen plasma bombardment. In general, oxygen plasma can both etch and oxidize the layer. Ghasemi *et al.* have shown that oxygen plasma can etch MoS₂ layers with a slow rate [20]. Thus, the applying oxygen plasma can etch some MoS₂ layers, but its major contribution will be in oxidizing the layers and increasing the energy band gap.

In this work, MoS_2 nanosheets were synthesized by sonication in NMP solvent and then deposited on pre-patterned gold electrodes. SEM, TEM, AFM, Raman and UV-Visible absorption analyzes were used to investigate the layered structure of nanosheets. After evaluating the optoelectronic properties of the MoS_2 photodetector, it was exposed to 200 W of oxygen plasma and showed that as the bombardment time increased to 180 s, the photoresponse of the MoS_2 is shifted from visible to ultraviolet region. In fact, oxygen bombardment replaces oxygen with sulfur atoms, and the band gap increases in MoS_2 and as a result it shows photoresponse only to higher-energy photons.

2. Experimental

2.1 Material supplies

MoS₂ powder with purity more than 99% and N-Methyl-2pyrrolidone (NMP) solvent were purchased from Sigma-Aldrich.

2.2 Material characterizations

TEM image was recorded by CM30, Philips microscope at operating voltage of 150 kV. Hitachi-S4160 SEM microscope was used to take the image of the device and sheets. Height profile of MoS₂ sheets were measured by NT-MDT AFM microscope in noncontact mode. Raman spectra of the samples were taken by Senterra Raman microscope spectrometer (532 nm laser). X-ray diffraction (XRD) analysis were performed using a Panalytical X'Pert PRO MPD system. A PG Instrument Ltd spectrophotometer was utilized to collect UV–visible absorption spectra. Electrical measurements were done with Keithly 2450 source measure unit in dark and under various laser illuminations at room ambient.

2.3 Synthesis of MoS₂ few layers

1 g of MoS_2 powders and 100 mL of NMP were mixed and stirred for 10 min. The solution was then exposed to a 300 W probe sonication for one hour. An ice bath was used to prevent the solution from heating up. The resulting solution was then centrifuged at 2000 rpm for 30 min, and top two-thirds of the obtained solution was collected for device fabrication and analysis.

3. Results and discussion

The solution containing MoS₂ nanosheets was prepared by sonication method in NMP solvent [21]. SEM, TEM and Raman analyzes were used to characterize it. Figure 1(a) presents the SEM image of MoS₂ sheets on a substrate. The sheets cover the entire surface and their approximate dimensions are about a few micrometers. Figure 1(b) shows the TEM image of a multilayer MoS₂ sheet on a grid. The edge of the sheet well prove its layered structure [11]. Figure 1(c) demonstrates the 3D image measured by the AFM analysis for deposited sheets on a substrate. According to it, thickness of the sheets is less than 30 nm.

Figure 2(a) shows the Raman spectrum of the MoS₂ sheets on

the substrate. The Raman spectrum of the multilayer MoS₂ consists of two peaks: the E^{1}_{2g} peak at position ~385 cm⁻¹, which is due to phonon oscillations inside the plane, and the A_{1g} peak at position ~407 cm⁻¹, which is due to phonon oscillations outside the plane [20]. Schematics of oscillation modes are also drawn in the Figure 2(a). Figure 2(b) shows the absorption spectrum of the NMP solution containing MoS₂ sheets. Accordingly, MoS₂ has a relatively good absorption in the range of 200 nm to 800 nm. Multilayers of MoS₂ also show two absorption peaks at 610 nm and 670 nm, called B and A peaks, respectively [22]. These two peaks are due to the direct transition of carriers at K point in the Brillouin zone [13]. There is also a strong absorption in the range of 390 nm to 500 nm in the spectrum due to the direct transitions of the carriers from the deep valence bands to the conduction band [23,24].

Figure 3 shows the fabrication process of the MoS₂ based photodetector. Accordingly, 300 nm of oxide was first grown on the silicon substrate. Then 100 nm of gold was deposited on the oxide layer (Figure 3(a)). By using a photolithography process, the gold layer was patterned and washed with acetone (Figure 3(b)). Next, a few drops of the MoS₂ solution were deposited on the sample (Figure 3(c)) and allowed to be dried at room temperature (Figure 3(d)).

Figure 4(a) displays the SEM image of the fabricated photodetector. Multi-layer of MoS₂ are deposited on the channel of the photodetector which connect the source and drain electrodes. The width of the channel is about 5 μ m. Figure 4(b) shows the electrical properties of the photodetector. In dark, a current of about 3 μ A passes through channel of the photodetector in the applied voltage range of -3 V to +3 V. Moreover, under 405 nm, 532 nm and 655 nm laser illuminations (with power of 1 mW) the current passing through the device channel increases. The highest photocurrent was observed for 405 nm and the lowest photocurrent for 655 nm. For 405 nm, photons generate more photocurrent due to their higher energy while in the case of 655 nm, photons generate less photocurrent as a result of their lower energy. However, the MoS₂-based photodetector shows that it responds well to 405 nm, 532 nm and 655 nm lasers, generating photocurrent in all three cases.



Figure 1. (a) SEM image of the deposited MoS₂ sheets, (b) TEM image of a multilayered MoS₂ sheet, and (c) AFM 3d-image of the deposited MoS₂ sheets on a substrate.



Figure 2. (a) Raman spectrum of the MoS₂ multilayers and their corresponding oscillation modes, and (b) UV-Visible absorption spectrum of the MoS₂ solution.



Figure 3. Fabrication process of the MoS_2 based photodetector: (a) Depositing of 100 nm gold on an oxide substrate, (b) Patterning of gold film by photolithography method, (c) Casting of MoS_2 solution on electrode, and (d) Drying the solution and drying the device.



Figure 4. (a) SEM image of the fabricated MoS_2 based photodetector, and (b) I-V curves of the device in dark and under 405 nm, 532 nm, and 655 nm laser illumination with power of 1 mW.

In the next step, the effect of oxygen plasma bombardment on the optoelectronic performance of the MoS₂ based photodetector was investigated. Figure 5(a) shows a schematic of the bombardment process. In order to prevent the negative effect of plasma on electrical contacts, the surface of the source and drain electrodes was passivated with epoxy glue. The device was then placed inside a quartz tube and oxygen gas with a flow of 20 sccm was introduced to bring the chamber pressure to 90 torr. Then 200 W oxygen plasma was applied to the samples in three times of 60 s, 120 s and 180 s and their electrical and optical properties were investigated. Figure 5(b) presents the currentvoltage curves of the devices after each stage of oxygen bombardment. It is observed that with increasing plasma time, the electrical resistance of the channel increases and less current passes through the channel. It is possible that the underlying MoS₂ layers of the channel, which remain intrinsic, are responsible for the passage of current. However, these underlying layers are less involved in the photocurrent generation process, and most of the photoexcited carriers generate in the upper layers. Then, the performance of the devices was examined under the irradiation of 405 nm, 532 nm and 655 nm lasers at 5 V biasing voltage and 5 mW output power. Figure 5(c) demonstrates the currenttime characteristics of all four photodetectors of MoS₂, 60-MoS₂, 120-MoS₂ and 180-MoS₂. For 405 nm radiation, photocurrent is generated in all four devices. The highest value is for as-prepared MoS₂ photodetector and the lowest is for 180-MoS₂. However, they all respond to 405 nm light. At 532 nm laser radiation, photocurrents are generated in MoS₂, 60-MoS₂, and 120-MoS₂ devices, but it is observed that the 180-MoS₂ sample does not show any optical response. A similar trend is observed for 655 laser radiation and no response is observed for the 180-MoS₂. Therefore, the 180-MoS₂ sample shows only an optical response under 405 nm illumination and no response is observed for longer wavelengths. Oxidation of the upper sheets of the channel and their local conversion to oxide is the reason for this behavior of 180-MoS₂ photodetector. Since the upper layers have the highest optical absorption, their oxidation will increase the chances of absorbing higher energy photons, while light illumination with higher wavelengths will have less absorption. As a result, the selectivity of the 180-MoS₂ photodetector will increase to 405 nm laser, and therefore will not respond to higher wavelengths. It should be noted that increasing the bombardment time beyond 180 s will etch the sheets and break down the electrical connection of the channel and the photodetector can no longer be used.

Figure 6(a) schematically shows the effect of oxygen bombardment on MoS₂ sheets. We believe that oxygen plasma leads to the oxidation of the upper layers of MoS₂, which play a major role in the absorption of light and the optical response of photodetectors. Figure 6(b) shows the SEM image of channel after 180 s of plasma bombardment. Accordingly, no significant etching effect is observed in the channel and most of the channel is covered by MoS₂ layers, even after plasma treatment. Figure 6(c) and (d) show XPS spectra of 2p orbital of sulfur in both MoS₂ and 180-MoS₂ samples with two peaks at around 164.3 eV and 163.1 eV corresponding $2P_{1/2}$ and $2P_{3/2}$ states. In the 180-MoS₂ sample, in addition to these two peaks, another peak is observed around 165.4 eV, which is due to O-S bonds and indicates that the surface of the MoS₂ layers has been oxidized and the O-S bonds have increased.



Figure 5. (a) Schematic of oxygen plasma bombardment of the MoS_2 based photodetector, (b) I-V curves of the MoS_2 and treated photodetectors, (c) Time trace measurement of the MoS_2 and treated photodetectors under 405 nm laser illumination (5 mW) at biasing voltage of 5 V, (d) Time trace measurement of the MoS_2 and treated photodetectors under 532 nm laser illumination (5 mW) at biasing voltage of 5 V, and (e) Time trace measurement of the MoS_2 and treated photodetectors under 532 nm laser illumination (5 mW) at biasing voltage of 5 V, and (e) Time trace measurement of the MoS_2 and treated photodetectors under 532 nm laser illumination (5 mW) at biasing voltage of 5 V, and (e) Time trace measurement of the MoS_2 and treated photodetectors under 655 nm laser illumination (5 mW) at biasing voltage of 5 V.



Figure 6. (a) Schematic of plasma treatment of MoS_2 sample and corresponding local oxidation, (b) SEM image of channel of $180-MoS_2$ photodetector, (c) XPS spectrum of 2p orbital of sulfur in MoS_2 sample, and (d) XPS spectrum of 2p orbital of sulfur in $180-MoS_2$ sample.



Figure 7. (a) Time trace measurement of the MoS_2 based photodetector under 405 nm illumination and operating voltage of 5 V, (b) Time trace measurement of the 180 s bombarded MoS_2 based photodetector under 405 nm illumination and operating voltage of 5 V, and (c) Raman spectra of the pristine MoS_2 , 60 s, 120 s, and 180 s bombarded MoS_2 samples.

Figure 7(a) shows the time trace response the MoS_2 based photodetector under 405 nm light illumination. The fall time of the photodetector was measured about 1.4 s, which refers to time taken for the current to return to its baseline. In the case of 180-MoS₂, shown in Figure 7(b), this time increases to more than 10 s due to the occurrence of trap states caused by oxygen bombardment [23,25]. Figure 7(c) compares the Raman spectrum of intrinsic MoS₂ and bombarded MoS₂ samples. According to the figure, as the bombing time increases, the general characteristics of the two E^{1}_{2g} and A_{1g} peaks are preserved, but the A_{1g} peak gradually shifts from 407 cm⁻¹ to 409 cm⁻¹ due to the removal of sulfur atoms in the upper MoS₂ layers in the channel of the photodetectors [20]. The results of various analyses lead to the following conclusion. Applying of oxygen plasma leads to oxidation of the upper layers of MoS₂ in the channel. SEM images before and after plasma treatment indicate that etching has not occurred, which is consistent with the work of others [20]. Raman analysis also shows that the whole plasma treated layer still has the property of MoS₂ and XPS analysis proved that the upper layer of MoS₂ are oxidized. Therefore, the results are completely consistent with our claim that only the upper layers, which play a significant role in the optical absorption of the photodetector, are oxidized and lead to a change in the energy band gap of the MoS₂.

4. Conclusions

MoS₂ is widely used in optoelectronic devices due to its attractive optical properties. In this work, multilayers of MoS₂ sheets were prepared by sonication method and then a MoS2-based photodetector was fabricated. SEM, TEM, AFM, Raman, XPS, and UV-Visible analyzes were used to control the photodetector fabrication process. The electrical and optical properties of the photodetector were then evaluated under 405 nm, 532 nm and 655 nm laser illuminations. Then, the photodetector was exposed to 200 W oxygen plasma for 60 s, 120 s and 180 s and the optical response of the photodetectors was studied at each stage. It was observed that in 180 s of radiation, the photodetector responds only to the 405 nm laser irradiation and no response is detected for longer wavelengths. Although, Raman analysis shows that the MoS₂ characteristic is preserved even after bombardment, the photo response region of the photodetector was tuned from visible to ultraviolet regions thanks to local oxidation of the MoS₂ sheets.

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